

TEMPERATURE AND DEPENDENCE OF PHOTOCONDUCTIVITY AND STRUCTURES $Mn_4Si_7-Si_{<Mn>-Mn_4Si_7}$

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ABSTRACT

This article studies the effect of infrared radiation and temperature on the parameters of higher manganese silicides on the surface of silicon created on the basis of impurity atoms of manganese. The possibility of creating effective thermocouples and photodetectors based on the structures of $Si_xMn_{1-x}-Si_{<Mn>-Mn_xSi_{1-x}}$ is shown.

Keywords: manganese, higher silicides, silicon, diffusion, contact, surface, infrared radiation, temperature.

Metal or silicide contacts with a high-impedance semiconductor are known to create potential energy that has a great influence on measurement results and on the operating parameters of semiconductor devices. This is due to the fact that when an external voltage is applied, one of the contacts shifts in the forward, and the other in the opposite direction.

For the study of the temperature dependence of photoconductivity, the structures $Si_4Mn_7-Si_{<Mn>-Si_4Mn_7}$ with a high-altitude base based on the original silicon of the KDB-10 brand were obtained. The study of the temperature dependence of the photoconductivity of the obtained structures of type $Mn_4Si_7-Si_{<Mn>-Mn_4Si_7}$ has established that at certain temperature values ($T = 150 \div 200$ K) there is a strong decrease in the photocurrent associated with it. As with temperature quenching of observed many semiconductor materials [1-4]. It has been established that the temperature quenching of photoconductivity is a thermoelectric feedback between the magnitude of the current and the temperature at the interface between the higher silicides of manganese (HCM) and silicon doped with impurity atoms of manganese $Si_{<Mn>}$. To explain the physical mechanism, it is necessary to consider the zone diagram of the structure under study [5-7]. The basic region of the structure $Si_{<Mn>}$ at low temperatures and illumination by its own light becomes a quasi-equilibrium hole hole conductivity with a current carrier concentration of the order $p \approx 10^{14} \text{ cm}^{-3}$. In this state, the Fermi quasi-level for holes E_{Fp} in the forbidden silicon zone is close to the ceiling at the valence band and takes a

value of $E_v + E_{Fp} = 0.18$ eV. By the various level of Fermi for electrons- E_{Fn} due to the adhesion of electrons to the levels of once ionized impurity atoms of manganese Mn^+ will rise from the middle of the band gap by the value $E_c - E_{Fn} \leq 0.3$ eV. When such a quasi-non-equilibrium state is in the zone, a slightly applied voltage leads to linear heating in the photocurrents and the resulting structures. Investigation of the temperature dependence of the photocurrent in such structures showed that there are many sites that are very different from each other [8].

The first section (increasing) has an inclination characterized by the activation energy of the level located on the lower half of the prohibited silicon zone $F_v + 0.18$ eV. When the structures in the base region are heated, electrons are generated from the valence band with a transition to the level $E_v + 0.18$ eV, since the quasi-level of Fermi E_{Fp} is below this level, which leads to a gap from the drag and from Electrons. At certain values, the temperature of the market fills the e lower level with electrons and the Fermi quasi-level for holes E_{Fp} shifts upwards (to the middle of the forbidden zone E_g). In this case, there is an increase in the concentration of holes in the valence band, which leads to a decrease in the temperature of the studied structures. In the process of heating the base, the base is displaced by the fermi quasi-level of electrons- E_{Fn} to the middle of the prohibited. However, the energy values of both the acceptor and donor levels of manganese differ almost twice. A change in photocurrent leads to an increase in the temperature of the base of structures based on silicon doped with manganese atoms, which affect each the energy levels in the corresponding temperature region. It is established that such electronic transitions in the structures $Mn_4Si_7-Si<Mn>-Mn_4Si_7$ occur in the temperature range $T = 80 \div 150$ K.

The second region, which relates to a rapid decrease in photocurrent with an increase in temperature in the range $T = 180 \div 200$ K, can be explained as follows. As the temperature rises, the Fermi quasi-level of electron- E_{Fn} begins to intersect with the level of manganese, and then shifts to the middle of the silicon band gap. This leads to thermal emission (thermal ejection) of electrons from Mn levels into the conduction band with their subsequent recombination through an uncontrolled level- N_r with valence zone holes. In turn, this leads to a decrease in the concentration of holes and, consequently, to an increase in the resistance of the basic region of the structure, i.e. temperature quenching of photoconductivity. The increase in resistance in the basic region of the structures, in turn, leads to a redistribution of the electric field in the transitional region of contact with the potential barrier. In the area of its base, as a result of which the rate of decrease in current is accelerated by more than 2.5-3 orders (Fig. 1).

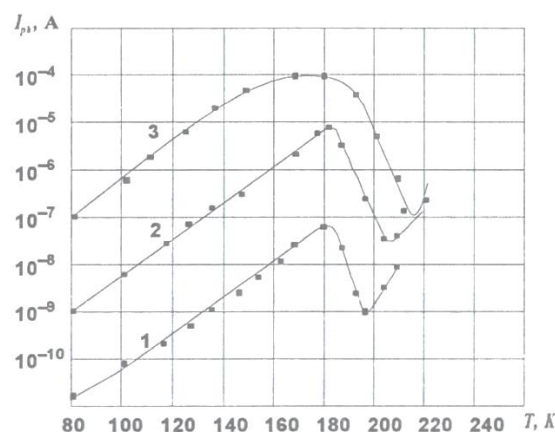


Figure 1. Temperature dependence of the photocurrent in the structures of HSR-Si<Mn>-HSR at different and applied voltages of 1-10 V; 2-100 V; curve 3-100 V.

From the analysis of the results of studies of photoelectric characteristics obtained by structure $Mn_4Si_7-Si<Mn>-Mn_4Si_7$ and $Mn_4Si_7-Si<Mn>-M$ at different radiation densities and applied electric field voltages from 50 to 100 V in the temperature range $T = 80 \div 240$ K. a region of negative differential photoconductivity

(ODPP) appears. It is also shown that the ODF P site shifts towards lower temperature values with a decrease in radiation intensity.

These results of the study once again showed the unique physical properties of the obtained structures and the possibility of creating thermal batteries, a photo receiver of IR radiation and temperature sensors on their basis.

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